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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,053	BULT ET AL.	
Examiner	Art Unit	
Brian Young	2819	

	SEAR	CHED	
Class	Subclass	Date	Examiner
341	143,136, 144 153, 162	9/26/2005	BY
257	143,136,	9/26/2005	BY

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		-	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (JPO, EPO, Derwent.(see attached) NPL (IEEE Explorer(search see attached)	9/26/2005	ВҮ

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